

# BUK7880-55

## N-channel TrenchMOS standard level FET

Rev. 3 — 21 April 2011

Product data sheet

## 1. Product profile

### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

### 1.2 Features and benefits

- AEC Q101 compliant
- Electrostatically robust due to integrated protection diodes
- Low conduction losses due to low on-state resistance

### 1.3 Applications

- Automotive and general purpose power switching

### 1.4 Quick reference data

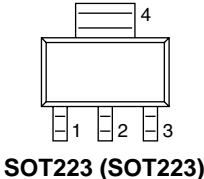
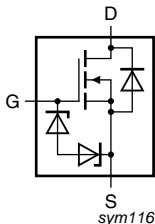
Table 1. Quick reference data

| Symbol                        | Parameter                                    | Conditions  | Min | Typ | Max | Unit       |
|-------------------------------|--|---|-----|-----|-----|------------|
| $V_{DS}$                      | drain-source voltage                         | $T_j \geq 25\text{ °C}; T_j \leq 150\text{ °C}$   | -   | -   | 55  | V          |
| $I_D$                         | drain current                                | $T_{sp} = 25\text{ °C}$   | -   | -   | 7.5 | A          |
| $P_{tot}$                     | total power dissipation                      | $T_{sp} = 25\text{ °C}; T_{amb} = 25\text{ °C}$   | -   | -   | 1.8 | W          |
| <b>Static characteristics</b> |  |   |     |     |     |            |
| $R_{DS(on)}$                  | drain-source on-state resistance             | $V_{GS} = 10\text{ V}; I_D = 5\text{ A}; T_j = 25\text{ °C}$  | -   | 65  | 80  | m $\Omega$ |
| <b>Avalanche ruggedness</b>   |  |   |     |     |     |            |
| $E_{DS(AL)S}$                 | non-repetitive drain-source avalanche energy | $I_D = 2.5\text{ A}; V_{sup} \leq 25\text{ V}; R_{GS} = 50\text{ }\Omega; V_{GS} = 10\text{ V}; T_{j(init)} = 25\text{ °C}; \text{unclamped}$ | -   | -   | 30  | mJ         |



## 2. Pinning information

**Table 2. Pinning information**

| Pin | Symbol | Description                          | Simplified outline   | Graphic symbol  |
|-----|--------|--------------------------------------|--|---|
| 1   | G      | gate                                 |  <p>SOT223 (SOT223)</p> |  <p>Sym116</p> |
| 2   | D      | drain                                |  |   |
| 3   | S      | source                               |  |   |
| 4   | D      | mounting base;<br>connected to drain |  |   |

## 3. Ordering information

**Table 3. Ordering information**

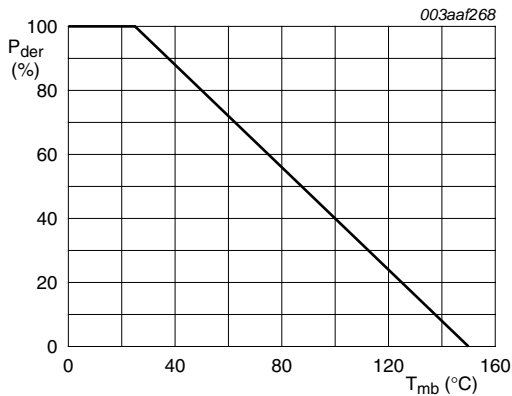
| Type number | Package |   | Version |
|-------------|---------|---|---------|
|             | Name    | Description   |         |
| BUK7880-55  | SOT223  | plastic surface-mounted package with increased heatsink;<br>4 leads | SOT223  |

## 4. Limiting values

**Table 4. Limiting values**

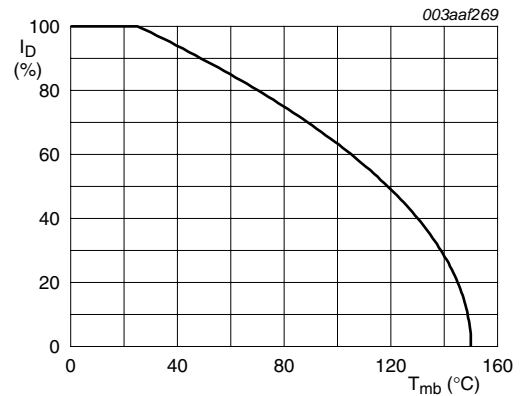
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol                         | Parameter                                    | Conditions  | Min | Max | Unit |
|--------------------------------|--|---|-----|-----|------|
| $V_{DS}$                       | drain-source voltage                         | $T_j \geq 25\text{ °C}; T_j \leq 150\text{ °C}$   | -   | 55  | V    |
| $V_{DGR}$                      | drain-gate voltage                           | $R_{GS} = 20\text{ k}\Omega$  | -   | 55  | V    |
| $V_{GS}$                       | gate-source voltage                          |   | -16 | 16  | V    |
| $I_D$                          | drain current                                | $T_{amb} = 25\text{ °C}$  | -   | 3.5 | A    |
|                                |  | $T_{sp} = 25\text{ °C}$   | -   | 7.5 | A    |
|                                |  | $T_{amb} = 100\text{ °C}$   | -   | 2.2 | A    |
| $I_{DM}$                       | peak drain current                           | $T_{sp} = 25\text{ °C};$ pulsed   | -   | 40  | A    |
| $P_{tot}$                      | total power dissipation                      | $T_{sp} = 25\text{ °C}; T_{amb} = 25\text{ °C}$   | -   | 1.8 | W    |
|                                |  | $T_{sp} = 25\text{ °C}$   | -   | 8.3 | W    |
| $T_{stg}$                      | storage temperature                          |   | -55 | 150 | °C   |
| $T_j$                          | junction temperature                         |   | -55 | 150 | °C   |
| <b>Source-drain diode</b>      |  |   |     |     |      |
| $I_S$                          | source current                               | $T_{sp} = 25\text{ °C}$   | -   | 7.5 | A    |
| $I_{SM}$                       | peak source current                          | pulsed; $T_{sp} = 25\text{ °C}$   | -   | 40  | A    |
| <b>Avalanche ruggedness</b>    |  |   |     |     |      |
| $E_{DS(AL)S}$                  | non-repetitive drain-source avalanche energy | $I_D = 2.5\text{ A}; V_{sup} \leq 25\text{ V}; R_{GS} = 50\ \Omega;$<br>$V_{GS} = 10\text{ V}; T_{j(init)} = 25\text{ °C};$ unclamped | -   | 30  | mJ   |
| <b>Electrostatic discharge</b> |  |   |     |     |      |
| $V_{esd}$                      | electrostatic discharge voltage              | HBM; $C = 100\text{ pF}; R = 1.5\text{ k}\Omega$  | -   | 2   | kV   |



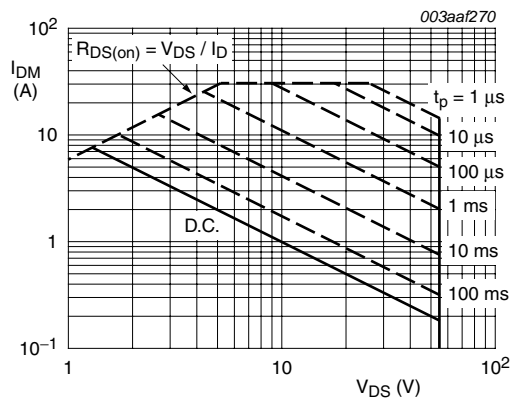
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

**Fig 1. Normalized total power dissipation as a function of solder point temperature**



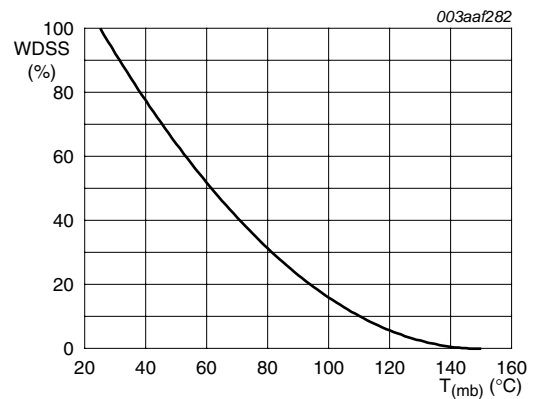
$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

**Fig 2. Normalized continuous drain current as a function of solder point temperature**



$T_{sp} = 25^{\circ}C$ ;  $I_{DM}$  is single pulse

**Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage**



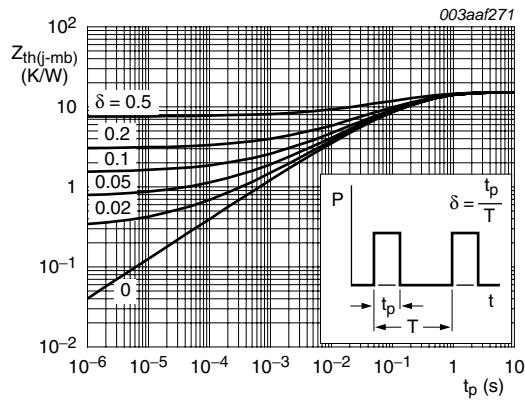
$I_D = 2.5 A$

**Fig 4. Normalised drain-source non-repetitive avalanche energy as a function of mounting-base temperature**

## 5. Thermal characteristics

**Table 5. Thermal characteristics**

| Symbol         | Parameter  | Conditions   | Min | Typ | Max | Unit |
|----------------|--|--|-----|-----|-----|------|
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point | mounted on any printed-circuit board                           | -   | 12  | 15  | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient      | Mounted on FR4 PCB, mounting pad for drain 6.5 cm <sup>2</sup> | -   | -   | 70  | K/W  |

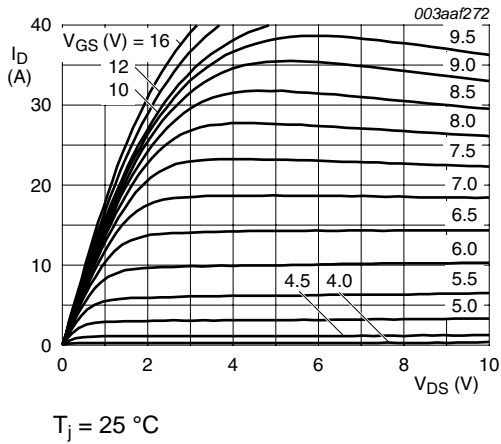


**Fig 5. Transient thermal impedance from junction to solder point as a function of pulse duration**

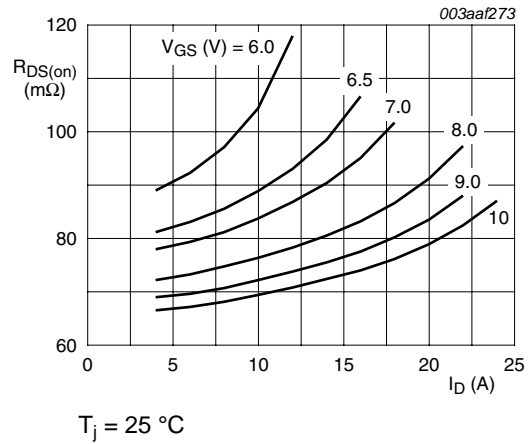
## 6. Characteristics

Table 6. Characteristics

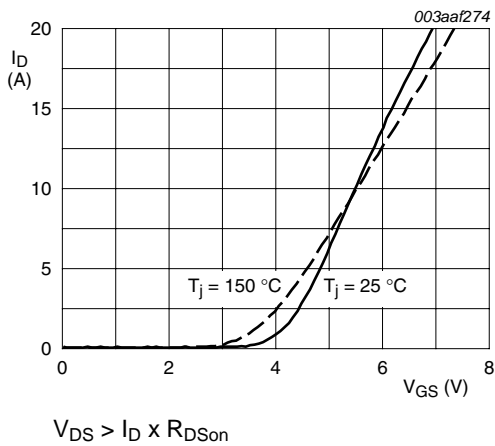
| Symbol                         | Parameter                        | Conditions   | Min | Typ  | Max | Unit          |
|--------------------------------|----------------------------------|--|-----|------|-----|---------------|
| <b>Static characteristics</b>  |                                  |  |     |      |     |               |
| $V_{(BR)DSS}$                  | drain-source breakdown voltage   | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$   | 55  | -    | -   | V             |
|                                |                                  | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ }^\circ\text{C}$  | 50  | -    | -   | V             |
| $V_{GS(th)}$                   | gate-source threshold voltage    | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ }^\circ\text{C}$  | 1.2 | -    | -   | V             |
|                                |                                  | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ }^\circ\text{C}$   | 2   | 3    | 4   | V             |
|                                |                                  | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ }^\circ\text{C}$  | -   | -    | 4.4 | V             |
| $I_{DSS}$                      | drain leakage current            | $V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$   | -   | 0.05 | 10  | $\mu\text{A}$ |
|                                |                                  | $V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ }^\circ\text{C}$  | -   | -    | 100 | $\mu\text{A}$ |
| $I_{GSS}$                      | gate leakage current             | $V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$   | -   | 0.04 | 1   | $\mu\text{A}$ |
|                                |                                  | $V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$  | -   | 0.04 | 1   | $\mu\text{A}$ |
|                                |                                  | $V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 150 \text{ }^\circ\text{C}$  | -   | -    | 10  | $\mu\text{A}$ |
|                                |                                  | $V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 150 \text{ }^\circ\text{C}$   | -   | -    | 10  | $\mu\text{A}$ |
| $R_{DS(on)}$                   | drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 5 \text{ A}; T_j = 150 \text{ }^\circ\text{C}$   | -   | -    | 148 | m $\Omega$    |
|                                |                                  | $V_{GS} = 10 \text{ V}; I_D = 5 \text{ A}; T_j = 25 \text{ }^\circ\text{C}$  | -   | 65   | 80  | m $\Omega$    |
| $V_{(BR)GSS}$                  | gate-source breakdown voltage    | $V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}; I_G = 1 \text{ mA}$  | 16  | -    | -   | V             |
|                                |                                  | $V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}; I_G = -1 \text{ mA}$   | 16  | -    | -   | V             |
| <b>Dynamic characteristics</b> |                                  |  |     |      |     |               |
| $C_{iss}$                      | input capacitance                | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}; T_j = 25 \text{ }^\circ\text{C}$  | -   | 365  | 500 | pF            |
| $C_{oss}$                      | output capacitance               |  | -   | 110  | 135 | pF            |
| $C_{rss}$                      | reverse transfer capacitance     |  | -   | 60   | 85  | pF            |
| $t_{d(on)}$                    | turn-on delay time               | $V_{DS} = 30 \text{ V}; R_L = 4.3 \text{ }^\Omega; V_{GS} = 10 \text{ V}; R_{G(ext)} = 10 \text{ }^\Omega; T_{mb} = 25 \text{ }^\circ\text{C}; I_D = 7 \text{ A}$                  | -   | 9    | 14  | ns            |
| $t_r$                          | rise time                        |  | -   | 15   | 25  | ns            |
| $t_{d(off)}$                   | turn-off delay time              |  | -   | 18   | 27  | ns            |
| $t_f$                          | fall time                        |  | -   | 12   | 18  | ns            |
| $g_{fs}$                       | transfer conductance             | $V_{DS} = 25 \text{ V}; I_D = 5 \text{ A}; T_j = 25 \text{ }^\circ\text{C}$  | 1   | 4    | -   | S             |
| <b>Source-drain diode</b>      |                                  |  |     |      |     |               |
| $V_{SD}$                       | source-drain voltage             | $I_S = 5 \text{ A}; V_{GS} = 0 \text{ V}; T_j \geq -55 \text{ }^\circ\text{C}; T_j \leq 175 \text{ }^\circ\text{C}$  | -   | 0.85 | 1.1 | V             |
| $t_{rr}$                       | reverse recovery time            | $I_S = 5 \text{ A}; di_S/dt = -100 \text{ A}/\mu\text{s}; V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}; T_j \geq -55 \text{ }^\circ\text{C}; T_j \leq 175 \text{ }^\circ\text{C}$ | -   | 38   | -   | ns            |
| $Q_r$                          | recovered charge                 |  | -   | 0.2  | -   | $\mu\text{C}$ |



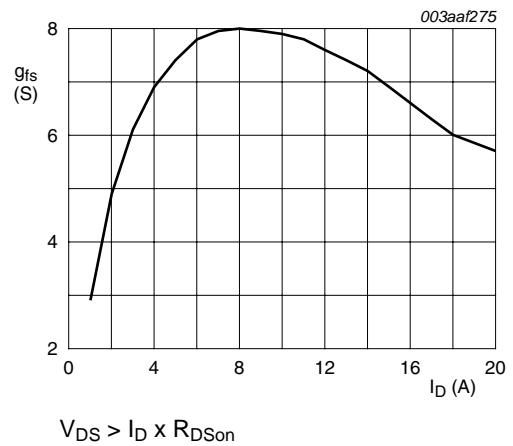
**Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values**



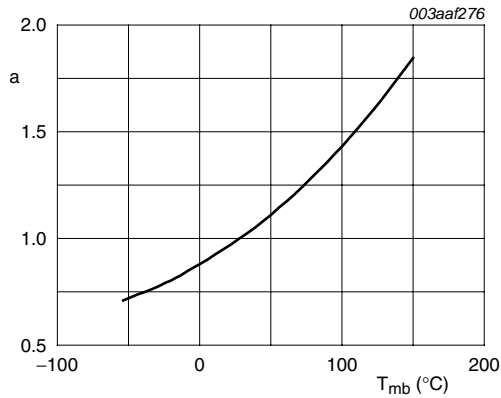
**Fig 7. Drain-source on-state resistance as a function of drain current; typical values**



**Fig 8. Transfer characteristics: drain current as a function of gate-source voltage; typical values**



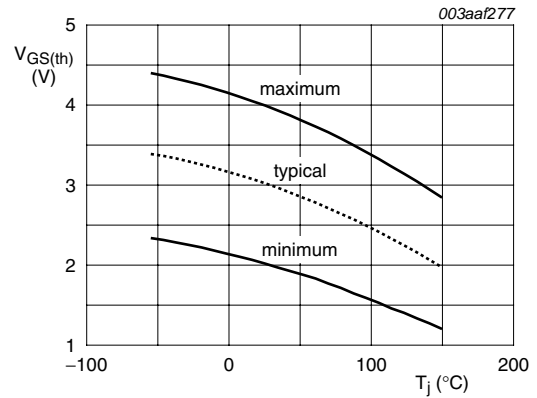
**Fig 9. Forward transconductance as a function of drain current; typical values**



$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

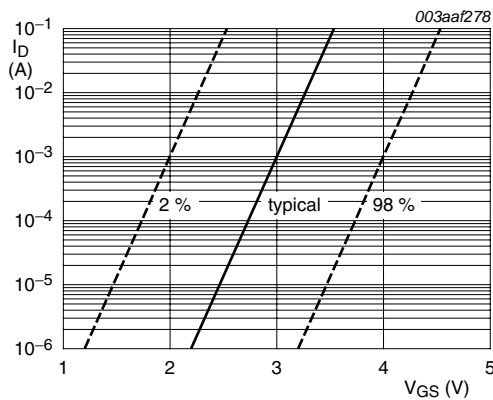
$I_D = 5 \text{ A}; V_{GS} = 10 \text{ V}$

**Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature**



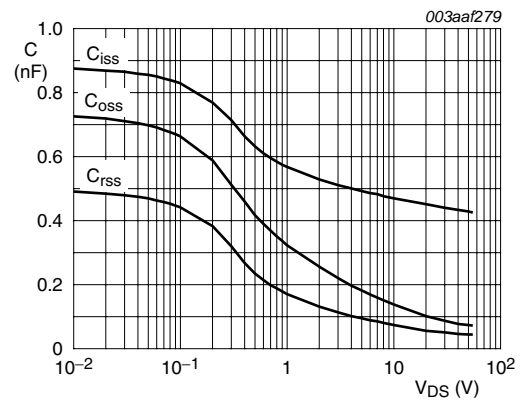
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

**Fig 11. Gate-source threshold voltage as a function of junction temperature**



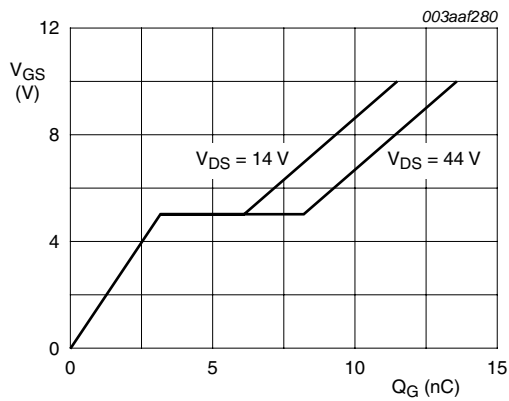
$T_j = 25^{\circ}C; V_{DS} = V_{GS}$

**Fig 12. Sub-threshold drain current as a function of gate-source voltage**



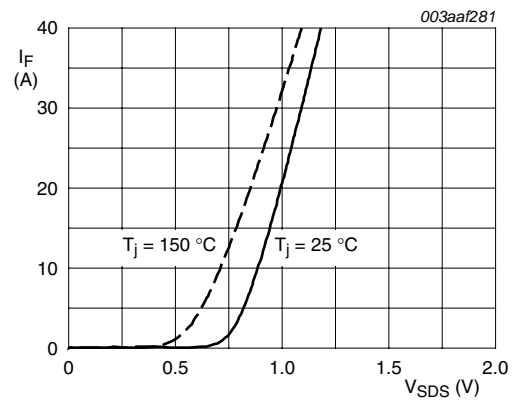
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

**Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**



$T_j = 25\text{ }^\circ\text{C}$ ;  $I_D = 7\text{ A}$

**Fig 14. Gate-source voltage as a function of gate charge; typical values**



$V_{GS} = 0\text{ V}$

**Fig 15. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values**



**7. Package outline**

Plastic surface-mounted package with increased heatsink; 4 leads

SOT223

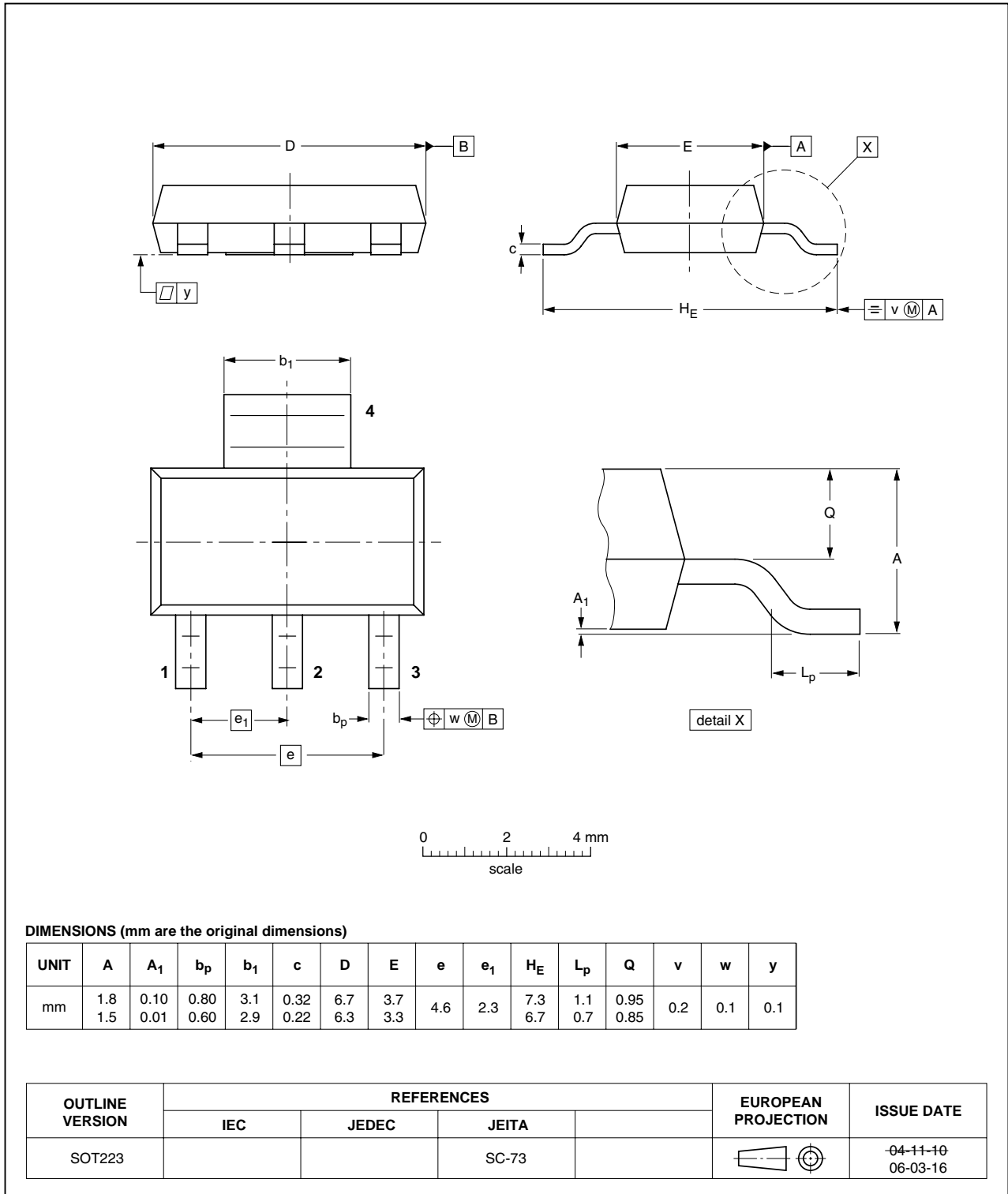


Fig 16. Package outline SOT223 (SOT223)

## 8. Revision history

Table 7. Revision history

| Document ID    | Release date   | Data sheet status     | Change notice | Supersedes   |
|----------------|--|-----------------------|---------------|--------------|
| BUK7880-55 v.3 | 20110421   | Product data sheet    | -             | BUK7880-55_2 |
| Modifications: | <ul style="list-style-type: none"><li>• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li><li>• Legal texts have been adapted to the new company name where appropriate.</li></ul> |                       |               |              |
| BUK7880-55_2   | 19980401   | Product specification | -             | -            |

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### 9.1 Data sheet status

| Document status <sup>[1]</sup> <sup>[2]</sup> | Product status <sup>[3]</sup> | Definition  |
|---|-------------------------------|---|
| Objective [short] data sheet                  | Development                   | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet                | Qualification                 | This document contains data from the preliminary specification.                       |
| Product [short] data sheet                    | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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